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July 2015

FDMC2512SDC

N-Channel Dual CoolTM 33 PowerTrench[®] SyncFETTM 25 V, 40 A, 2.0 m Ω

Features

- Dual CoolTM Top Side Cooling PQFN package
- Max $r_{DS(on)}$ = 2.0 m Ω at V_{GS} = 10 V, I_D = 27 A
- Max $r_{DS(on)} = 2.95 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 22 \text{ A}$
- High performance technology for extremely low r_{DS(on)}
- SyncFET Schottky Body Diode
- RoHS Compliant

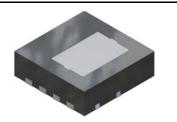


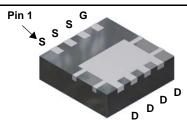
General Description

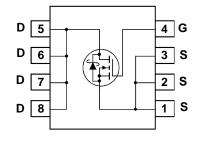
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. Advancements in both silicon and Dual CoolTM package technologies have been combined to offer the lowest r_{DS(on)} while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side







Top Dual CoolTM 33 Bottom

MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			25	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		40	
	-Continuous (Silicon limited) T _C = 25			148	Α
ID	-Continuous	T _A = 25 °C	(Note 1a)	32	_ A
	-Pulsed			200	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	144	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 5)	1.8	V/ns
P _D	Power Dissipation	T _C = 25 °C		66	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	3.0	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	4.5	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.9	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	

Package Marking and Ordering Information

Device M	arking	Device	Package	Reel Size	Tape Width	Quantity
2512	:S	FDMC2512SDC	Dual Cool TM 33	13"	12 mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20 V, V _{GS} = 0 V			500	μΑ
I_{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	1.2	1.7	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		-4		mV/°C
		$V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}$		1.6	2.0	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 22 \text{ A}$		2.4	2.95	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}, T_J = 125 ^{\circ}\text{C}$		2.2	2.8	
9 _{FS}	Forward Transconductance	$V_{DD} = 5 \text{ V}, I_{D} = 27 \text{ A}$		154		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 42.V.V 0.V	3315	4410	pF
C _{oss}	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	1010	1345	pF
C _{rss}	Reverse Transfer Capacitance	I = I IVITIZ	168	255	pF
R_g	Gate Resistance		1.2	2.1	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		14	26	ns
t _r	Rise Time	V _{DD} = 13 V, I _D = 27 A,	7	14	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	34	55	ns
t _f	Fall Time		5	10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	49	68	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V}$	22	31	nC
Q _{gs}	Gate to Source Gate Charge	I _D = 27 A	11		nC
Q _{gd}	Gate to Drain "Miller" Charge		5.5		nC

Drain-Source Diode Characteristics

V	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 27 \text{ A}$	(Note 2)	8.0	1.2	\/
V _{SD}	Source to Drain blode Forward voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2 \text{ A}$	(Note 2)	0.43	0.8	V
t _{rr}	Reverse Recovery Time	I - 27 A di/dt - 200 A/v		30	48	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 27 \text{ A, di/dt} = 300 \text{ A/}\mu\text{s}$		29	46	nC

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	4.5	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.9	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	19	90044
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

NOTES:

1. $R_{\theta,JA}$ is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 42 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 105 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 \mbox{in}^2 pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} of 144 mJ is based on starting $T_{J} = 25$ ^{o}C ; N-ch: L = 1 mH, $I_{AS} = 17$ A, $V_{DD} = 23$ V, $V_{GS} = 10$ V. 100% test at L = 0.3 mH, $I_{AS} = 25$ A.
- 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.
- 5. $I_{SD} \le 27$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25 oC .

Typical Characteristics $T_J = 25$ °C unless otherwise noted

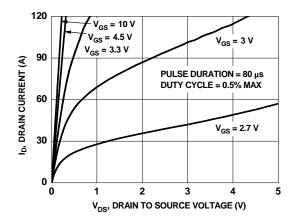


Figure 1. On-Region Characteristics

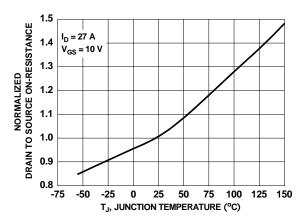


Figure 3. Normalized On-Resistance vs Junction Temperature

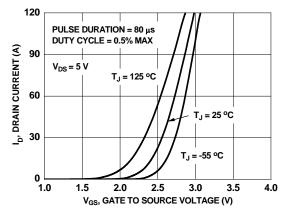


Figure 5. Transfer Characteristics

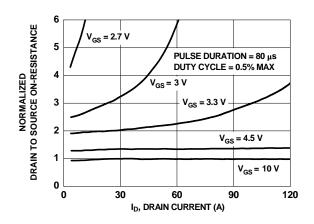


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

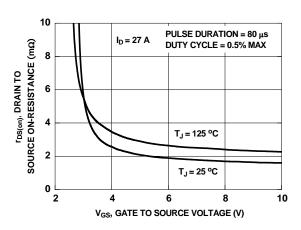


Figure 4. On-Resistance vs Gate to Source Voltage

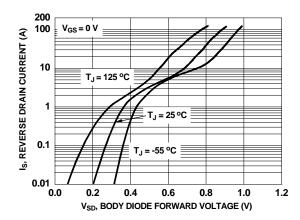


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

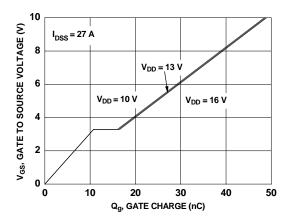


Figure 7. Gate Charge Characteristics

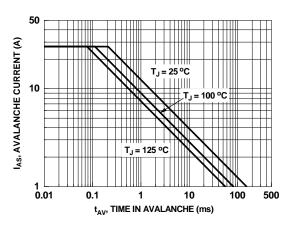


Figure 9. Unclamped Inductive Switching Capability

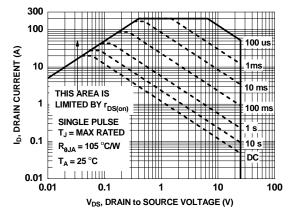


Figure 11. Forward Bias Safe Operating Area

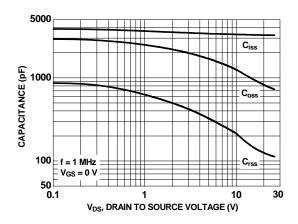


Figure 8. Capacitance vs Drain to Source Voltage

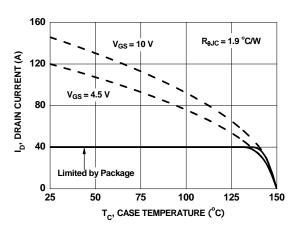


Figure 10. Maximum Continuous Drain Current vs Case Temperature

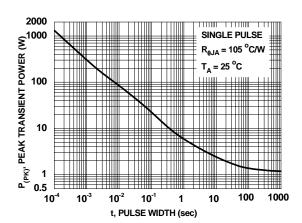


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

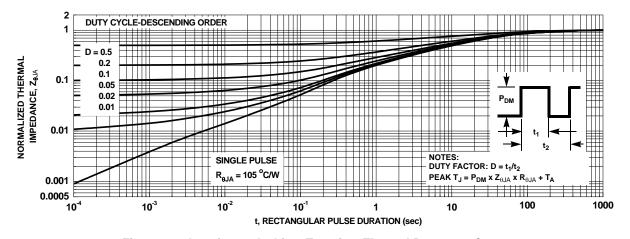


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMC2512SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

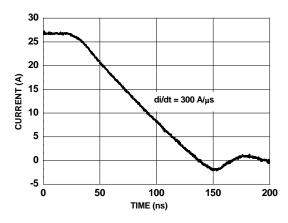


Figure 14. FDMC2512SDC SyncFET body diode reverse recovery characteristic

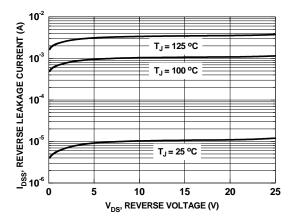
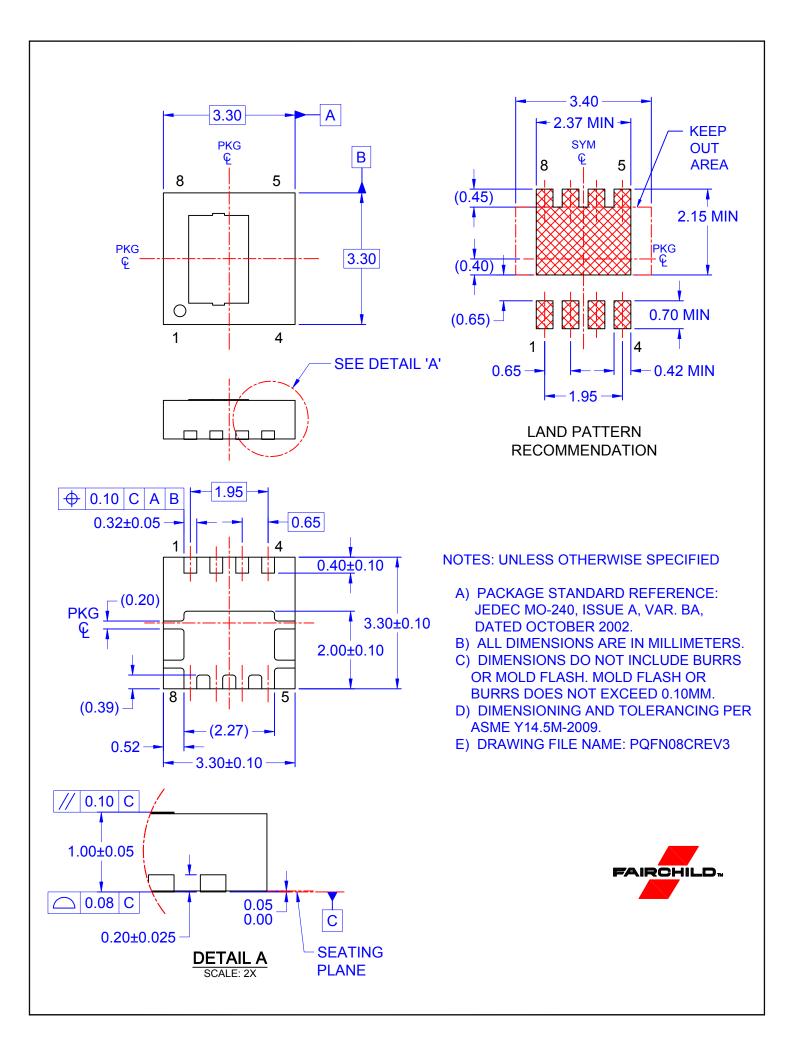


Figure 15. SyncFET body diode reverse leakage versus drain-source voltage



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